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O I P E JAN 12 2004 U.S. PATENT & TRADEMARK OFFICE Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BENDALE ET AL	
		100/159,265	Examiner Eric W Thomas	Art Unit 2831

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
1m	A	US-6,282,081	08-2001	Takabayashi et al.	361/502
1m	B	US-2002/0110729	08-2002	Hozumi et al.	429/130
	C	US-		/	
	D	US-		/	
	E	US-		/	
	F	US-		/	
	G	US-		/	
	H	US-		/	
	I	US-		/	
	J	US-		/	
	K	US-		/	
	L	US-		/	
	M	US-		/	

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
1m	N	1033729	09-2000	EP	Miura et al.	H01G 9/12
1m	O	9/298129	11-1997	JP	—	H01G 9/00
	P			/		
	Q			/		
	R			/		
	S			/		
	T			/		

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	/
	V	/
	W	/
	X	/

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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